Notice of References Cited Application/Control No. 09/938,923 Applicant(s)/Patent Under Reexamination YUAN ET AL. Examiner Bob A. Phunkulh Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,065,398	11-1991	Takashima, Hideo	370/230
	В	US-5,396,643	03-1995	Frenzer et al.	340/7.27
	С	US-5,432,777	07-1995	Le Boudec et al.	370/397
	D	US-5,517,497	05-1996	Le Boudec et al.	370/399
	E	US-5,563,879	10-1996	Sanders et al.	370/474
	F	US-5,600,629	02-1997	Van Daele et al.	370/349
	G	US-5,852,721	12-1998	Dillon et al.	709/217
	н	US-5,909,439	06-1999	Kuwabara et al.	370/389
	1	US-6,172,972	01-2001	Birdwell et al.	370/349
	J	US-			
	к	US-			
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	a					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	v	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.